Ion Migration in Organometal Trihalide Perovskite and Its Impact on Photovoltaic Efficiency and Stability

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CONSENSUS: Organometal trihalide perovskites (OTPs) are emerging as very promising photovoltaic materials because the power conversion efficiency (PCE) of OTP solar cells quickly rises and now rivals that of single crystal silicon solar cells after only five-years research. Their prospects to replace silicon photovoltaics to reduce the cost of renewable clean energy are boosted by the low-temperature solution processing as well as the very low-cost raw materials and relative insensitivity to defects. The flexibility, semitransparency, and vivid colors of perovskite solar cells are attractive for niche applications such as built-in photovoltaics and portable lightweight chargers. However, the low stability of current hybrid perovskite solar cells remains a serious issue to be solved before their broad application. Among all those factors that affect the stability of perovskite solar cells, ion migration in OTPs may be intrinsic and cannot be taken away by device encapsulation.

The presence of ion migration has received broad attention after the report of photocurrent hysteresis in OTP based solar cells. As suggested by much direct and indirect experimental evidence, the ion migration is speculated to be the origin or an important contributing factor for many observed unusual phenomenon in OTP materials and devices, such as current--voltage hysteresis, switchable photovoltaic effect, giant dielectric constant, diminished transistor behavior at room temperature, photoinduced phase separation, photoinduced self-poling effect, and electrical-field driven reversible conversion between lead iodide (PbI₂) and methylammonium lead triiodide (MAPbI₃). Undoubtedly thorough insight into the ion-migration mechanism is highly desired for the development of OTP based devices to improve intrinsic stability in the dark and under illumination. In this Account, we critically review the recent progress in understanding the fundamental science on ion migration in OTP based solar cells. We look into both theoretical and experiment advances in answering these basic questions: Does ion migration occur and cause the photocurrent hysteresis in perovskite solar cells? What are the migrating ion species? How do ions migrate? How does ion migration impact the device efficiency and stability? How can ion migration be mitigated or eliminated? We also raise some questions that need to be understood and addressed in the future.

1. INTRODUCTION

The ion-migration behavior in organometal trihalide perovskites (OTPs) had not cause strong interest until the report of obvious photocurrent hysteresis in OTP solar cells, despite ion migration in halide based perovskite materials being known for over 30 years.¹ At the 2013 MRS fall meeting, Hoke and Snaith reported the presence anomalous photocurrent density--voltage (J--V) hysteresis in mesostructure OTP devices (Figure 1a) and Snaith speculated ion migration driven by the electric field to be one of the three possible origins of photocurrent hysteresis.² Xiao et al. discovered the giant switchable photovoltaic effect in early 2014 where the photocurrent direction was completely flipped during scanning in OTP solar cells with a planar heterojunction structure and symmetric electrode.³ This provided the first evidence for the electric-field changed morphology of the OTP materials and proved that the ion migration effect was a very important contribution to the photocurrent hysteresis by excluding the other two possible factors such as ferroelectricity. Switchable device polarity was also observed in OTP solar cells with different device configurations (both vertical and lateral structure), different hybrid perovskite materials (e.g., methylammonium (MA) lead triiodide (MAPbI₃), methylammonium lead bromide (MAPbBr₃), and formamidinium lead triiodide (FAPbI₃)), or different electrode materials (e.g., gold (Au), platinum, nickel, carbon, or gallium), demonstrating that ion migration is general and intrinsic to the OTP materials. Later, Tress et al.⁴ also

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suggested ion migration among other mechanisms as a contribution for the photocurrent hysteresis although no direct evidence of ion migration was shown.

More unusual phenomena have been observed on OTP materials and devices, which may also originate from the ion-migration effect. One example is the open challenge to obtain a high-mobility OTP transistor despite the reported Hall mobilities of OTP materials (≈100 cm²/(V s) for MAPbI₃) being comparable to that of silicon.

This can be explained by the screening of the gate field by the accumulation of migrated ions at the gate dielectric/perovskite interface. Chin et al. showed that cooling the OTP transistor devices to freeze the ion migration (<200 K) made the MAPbI₃ transistor work with a reasonably good mobility. The other example is the giant static dielectric constant of OTP materials (∼10⁶ for MAPbI₃(Cl)₄) measured under one sun illuminating conditions at low frequency (≈0.1 Hz), as reported by Juarez-Perez et al. Ion conduction was shown to be one possible origin of the photoinduced giant permittivity and 1/f dependent on static dielectric constant.

Other possible origins such as charge-trapping effects may also cause the giant static dielectric constant.

In this Account, we provide a critical review on the advances in understanding ion-migration science in OTP materials from both theoretical and experimental aspects and summarize its impacts on perovskite photovoltaic device stability and efficiency. Here we focused on the material of MAPbI₃ because it has been heavily studied for solar cell applications with very high efficiency obtained, although ion migration also was shown to occur for all other OTP materials.

2. WHAT IS MIGRATING IN THE OTP FILMS UNDER THE ELECTRIC FIELD?

The first question to be answered for ion migration is which ion or ions migrate in the MAPbI₃ films. Any of the constituting ions (i.e., I⁻, Pb²⁺ and MA⁺) may migrate. Additional species resulting from material decomposition or contamination, such as H⁺, may also join the game. How easily an ion migrates in a solid material is characterized by the activation energy (E_A), and the migration rate (r_m) is influenced by the E_A as

\[ r_m \propto \exp \left( -\frac{E_A}{k_B T} \right) \]

where k_B and T are Boltzmann constant and temperature, respectively, and k_B T represents thermal activation energy. The E_A is sensitive to the material’s crystal structure, ionic radius, ion-jumping distance, and the charge of ions. Generally ions migrate faster in crystals with more and bigger available interstitial sites, smaller and less charged ions, and smaller jumping distance. Taking the well-studied ABO₃ structure oxide perovskites as analogy, I⁻ may be the migrating species in MAPbI₃, analogous to the O²⁻ ions in the oxide perovskites. In the MAPbI₃, the I⁻ ions in the edge of the PbI₆ octahedron (path A in Figure 2b) with the lowest E_A of 0.58 eV; the migrating of MA⁺ in the (100) plane along (100) direction (path D in Figure 2b) has a higher E_A of 0.84 eV, and the Pb²⁺ migrating along the diagonal of the unit cell ([110] direction, path B in Figure 2b) has a much higher E_A of 2.31 eV. Eames et al. derived an E_A of 0.60–0.68 eV from photocurrent relaxation at biased preconditioning, which is close to their calculated E_A of I⁻ ion migration. The majority of mobile ions were hence suggested to be the I⁻ ions, which are estimated to have a diffusion coefficient of 10⁻¹² cm² s⁻¹ at 320 K. In another

Figure 1. Typical photocurrent curves of OTP solar cells with nonsymmetrical (panel a, Reproduced with permission form ref 2c. Copyright 2014 Nature Publishing Group) and symmetrical electrode work functions (b) and (c) schematics of ion migration in perovskite during positive and negative poling, respectively. Panel b and c reproduced with permission form ref 3. Copyright 2015 Nature Publishing Group.
theoretical work, Azpiroz et al. calculated the $E_A$ to be 0.08, 0.80, and 0.46 eV for the $I^-$, Pb$^{2+}$ (path C in Figure 2b), and MA$^+$ ions, respectively. Due to the very small $E_A$ for $I^-$ ions, Azpiroz et al. estimated that the $I^-$ ions can migrate through the MAPbI$_3$ film within 1 μs, which is too fast to explain the hysteresis effect or photovoltaic switch rate in the MAPbI$_3$ devices (typically in a time scale of 0.1–100 s). The majority ions that cause the observed slow current response was hence suggested by Azpiroz et al. to be MA$^+$ or Pb$^{2+}$ ions. Later, Haruyama et al.’s calculation gave an $E_A$ of 0.33 eV for $I^-$ migration and an $E_A$ of 0.55 eV for MA$^+$ migration. To summarize, although the different computational models gave very different $E_A$ values, their concensus is that $I^-$ ions are more readily mobile than MA$^+$ and Pb$^{2+}$ ions. It is noted that none of these models consider ion migration through the interstitial sites (Frenkel defects). However, the calculated formation energies of the interstitial defects for $I^-$ (0.23–0.83 eV) and MA$^+$ (0.20–0.93 eV) are actually close to the $E_A$ for $I^-$ (e.g., 0.58 eV) and MA$^+$ (e.g., 0.84 eV) migration. This indicates that more theoretical work needs to consider other possible ion migration scenarios to understand ion migration in OTPs. H$^+$ is the only species that has been speculated to migrate through Frenkel defects because of its smallest size. Egger et al. calculated an $E_A$ of 0.29 eV for H$^+$ migrates along a transient hydrogen bond connecting two equatorial iodides. It is vital to have experimental evidence to verify this possibility.

The first experimentally confirmed migrating species was MA$^+$. The recently developed photothermal induced resonance (PTIR) microscopy enables the direct imaging of MA$^+$ distribution because it combines the Fourier transform infrared spectroscopy (FTIR) chemical signal and AFM imaging capability. Yuan et al. observed a redistribution of MA$^+$ ions (Figure 2c) after an electric poling in a lateral MAPbI$_3$ solar cell. After application of a small electrical field of 1.6 V/μm for 100 s, MA$^+$ ions depleted from the center and the anode region and accumulated around the cathode region (Figure 2c).
which is direct evidence for MA+ migration. In Yuan et al.’s study, the $E_A$ for ion migration was estimated from the conductivity ($\sigma$) changes of the MAPbI$_3$ film at different temperatures. The measured $E_A$ of 0.36 eV is somewhat smaller than the value for MA+ ions predicted by the first principles method (0.46 or 0.84 eV). The inconsistency is not surprising because the calculated $E_A$ is responsible to the ion migration occurring in a bulk crystal, while the measured ionic conductivity might be dominated by the ion migration at grain boundaries. Further studies on ionic conductivity using single crystals might help resolve this discrepancy. Another possibility is that the measured $E_A$ represents the migration of other ions, such as I$^-$. Nevertheless no obvious I$^-$ redistribution was observed within the resolution of energy-dispersive X-ray spectroscopy (EDX).

Although theoretical calculations predicted the I$^-$ ions to be the most mobile ions in the MAPbI$_3$ films, the migration of I$^-$ ion at room temperature under device operation conditions has not been verified yet. Whether I$^-$ ions migrate at room temperature remains elusive. Yang et al. offered a hint pointing to possible I$^-$ migration at elevated temperature. In their study, the MAPbI$_3$ film was embedded in a solid-state electrochemical cell with the structure Pb-anode/MAPbI$_3$/AgI/Ag-cathode. After application of a DC bias for a week at 323 K (Tubandt’s method), formation of lead iodide (PbI$_2$) at the Pb-anode/MAPbI$_3$ interface was observed, which could be the reaction product of the migrated I$^-$ with the Pb-anode. However, it can also be explained by the decomposition of the MAPbI$_3$ due to the leaving of MA$^+$ from the region close to the anode, which was observed in Xiao’s study. In another investigation, Yuan et al. studied the electrical poling effect on the lateral MAPbI$_3$ solar cells at elevated temperature of 330 K and observed the formation of a “PbI$_2$ thread” with a width of 5–15 $\mu$m that could migrate along the applied electrical field (3 V/$\mu$m, Figure 2d). The migration of the PbI$_2$ thread was explained by a field-driven reversible conversion between MAPbI$_3$ and PbI$_2$ phases due to a massive migration of MA$^+$ ions and I$^-$ ions. This provided the first experimental evidence for the massive migration of I$^-$ vacancies in macroscale at elevated temperature. This result supports that both the MA$^+$ ions and I$^-$ ions migrate in the MAPbI$_3$ films at a relative small electrical field of 3 V/$\mu$m at 330 K, while the Pb$^{2+}$ remains immobile within the resolution of the EDX measurement. Meanwhile, the experimental study of migration of H$^+$ is challenging because of the potential severe contamination issues and difficulty in measuring H$^+$ distribution, which might need to resort neutron scattering study in the future.

### 3. WHAT ARE THE ION MIGRATION CHANNELS IN SOLID PEROVSKITE FILMS?

Understanding how the mobile ions migrate under electric fields in perovskite films is of great importance since it could provide hints for the development of OTP materials with improved stability for solar cell application. Like diffusion processes, ion migration under electric field must be mediated by the defects in perovskite solid films. The fact that the OTP single crystals have much narrower X-ray diffraction peaks than those polycrystalline films indicates that the regular thin films have a large density of point defects or lattice distortion. Theoretical calculations indicate that Pb$^{2+}$ vacancies or MA$^+$ interstitials have low formation energy in MAPbI$_3$ films, but there have been no experiment evaluation of this prediction yet. A large density of point defects could be generated in the OTP films for solar cells because (1) the quick formation of...
OTP films or crystallization of grains at low temperature by solution or thermal-evaporation processes, which are broadly applied for solar cell film fabrication, inevitably generate many defects in perovskite films, (2) in many cases, the precursor ratio is not stoichiometric in fabricating the high performance OTP solar cells,17 and (3) theoretically MAPbI₃ has a very low calculated decomposition energy barrier of 0.1 eV due to the “softness” of the chemical bonding.18 The easy-decomposition nature of MAPbI₃ has the same origin as the low defect-formation energy. Kim et al. calculated that the formation energy of Pb—I vacancy pairs (Schottky defects, Figure 3a) in MAPbI₃ is only 27–73 meV.19 The “softness” also explains why the $E_a$ for ion migration in MAPbI₃ (0.36 eV) with large atoms is smaller than that of other perovskite oxides with smaller atoms, such as LaFeO₃ (0.77 eV), LaMnO₃ (0.73 eV), and LiNbO₃ (0.75 eV).

In addition to bulk point defects, the surface and grain boundaries of the crystal grain are other extremely important ion migration channels (Figure 3c). The reported models only considered the ion migration through the bulk point defects, while Xiao et al.’s switchable photovoltaic study already showed that ion migration might be dominated by the grain boundaries in polycrystalline films, because the devices with large-grain films were much more difficult to switch than small-grain films.56 Due to the relatively open structure at grain boundaries and surfaces, the $E_a$ for ion migration at grain boundaries and surfaces is roughly half that in the bulk since only half of the chemical bonds are reserved. In addition, most of the solar cell films go through a thermal-annealing process, which might evaporate partial organic species away from the grain boundaries, leaving relatively open space at grain boundaries.20 Despite the much lower $E_a$ the ion migration cross-section area along grain boundaries is much smaller than that for bulk migration. Therefore, more studies, both theoretical and experimental, are needed to find out which channel dominates the ion migration in regular polycrystalline thin films used for solar cells. In Yuan et al.’s study of ion migration in a polycrystalline film along the lateral direction, it was found that some ions began to move at a relative smaller electrical field of ~0.1 V/μm (named “fast ions”) and some ions began to move at electrical field of >0.3 V/μm (named “slow ions”). The origins of “fast ions” and “slow ions” have not been identified yet, which may be caused by ion migration through different channels, that is, through the bulk or the grain boundaries or film surface, by the migration of different species with different $E_a$ or by the combination of them.31

In addition, there are some other possibilities for the generation of ion migration channels, such as the local lattice distortion caused by mesoporous scaffold confinement, accumulated charges (Figure 3d),20 small dissolved clusters due to absorbed molecules (Figure 3e),21 and strains due to piezoelectric effect (Figure 3f). Choi et al. found that most MAPbI₃ (70%) within the mesoporous TiO₂ was highly disordered with local perovskite coherence length of only 1.4 nm, which might explain more severe photocurrent hysteresis in mesoporous structure devices in addition to the trapping effect.21 It is known that OTP can easily absorb many kinds of chemicals, such as moisture24 and polar organic molecules, like dimethylformamide (DMF),25 dimethyl sulfoxide (DMSO),26,18,23 and MA.26 These residual molecules in OTP films can open up the crystal structure significantly, which facilitates ion migration. Wu et al. studied charge accumulation in OTP based solar cells and suggested possible lattice distortion caused by accumulated charges, which was used to explain the observed device hysteresis.27 Dong et al. observed electrical field-induced strain in OTP single crystals due to their piezoelectric nature, which promotes ion migrations.27 In addition, Gottesman et al.’s calculation suggests a reduced binding between MA⁺ and the inorganic frame under illumination.28 This photoinduced lattice softness also increases the defect formation and thus ion migration (Figure 3g).

4. IMPACT OF THE ION MIGRATION ON PHOTOVOLTAIC EFFICIENCY AND STABILITY

It is now broadly believed that ion migration can cause the notorious photocurrent hysteresis problem.29,30 The photo-current hysteresis brings difficulty in accurate characterization of the device efficiency, and there are also concerns that ion migration impairs the stability of the OTP solar cells. One example is the occurrence of serious phase segregation in mixed halide MAPbBr₃—I₃ films under illumination as observed by Hoke et al.30 The homogeneous MAPbBr₃—I₃ films on a mesoporous scaffold were shown to be unstable under illumination with a photoexcited phase-separation into two phases, one iodine-rich phase and one iodine-poor phase, as proven by the splitting of X-ray diffraction (XRD) peaks and PL peaks (Figure 4a,b).30 The lower bandgap phase thus acts as a charge trap, which was hypothesized to be responsible to the severely reduced open circuit voltage ($V_{OC}$) and power conversion efficiency (PCE) of the MAPbBr₃—I₃ devices. The $E_a$ for halide-ion migration measured by Hoke et al. was ~0.27 eV, which is close to that of halide ion migration in other pure halide perovskite materials, such as MAPbI₃, CsPbCl₃ or CsPbBr₃.4 The much stronger ion migration in the mixed halide perovskite might be caused by the lattice mismatch with different halide anion radius. This halide segregation in MAPbBr₃—I₃ was shown to be reversible when the films were stored in the dark for a few minutes, indicating that the MAPbBr₃—I₃ film has different stable states in the dark and under illumination. Further study is needed to find out whether this is a spinodal decomposition.31 It is not clear whether the photoinduced lattice softness effect proposed by Gottesman et al. contributes to the ion migration induced by light illumination.28 On the other hand, it is of interest to find out whether this ion migration is promoted by the local electrical field caused by the redistribution of photogenerated charge carriers or trapped charges. More insights are needed regarding the role of light illumination in favoring ion migration.

On the other hand, ion migration does not necessarily cause the reduction of device efficiency or stability. In Xiao et al.’s study with a device structure of indium tin oxide (ITO)/poly(3,4-ethylenedioxythiophene)—polystyrene sulfonate (PEDOT:PSS)/perovskite/Au, electric poling caused ion migration generated p−i−n structure, which resulted in a switchable current circuit ($J_{SC}$) of ~20 mA/cm² and a switchable $V_{OC}$ of ~1 V. This demonstrates that the ion redistribution has an overwhelming tuning effect on the photovoltaic effect and efficiency. The electric poling can also induce the formation of lateral p−i−n structure, which enables coplanar structure in solar cells. Lateral OTP solar cell arrays with the formed p−i−n junctions connected in series were demonstrated, which output a very large $V_{OC}$ of 70 V and have potential in eliminating the use of expensive transparent electrodes.17 One potential issue is again the stability of the doping structure. The doping formed by electric poling is caused by the accumulated defects through...
ion migration, while the ion back diffusion in the absence of the applied field could eventually null the doping effect, which was observed to occur in a few days after poling.

Further studies carried out on lateral solar cells confirmed that ions in MAPbI$_3$ started to migrate at a small electrical field (~3 V/μm), which is much smaller than the built-in electrical field in most of the OTP solar cells (~1000 V/μm). This suggests that the photovoltage induced additional electric field is comparable to the built-in electric field, which should also cause ion back migration when the device is under illumination. In Deng et al.’s study, it was found that the light induced self-poling effect (LISP) had the same effect as electric poling (Figure 4c,d). The pristine device started with a poor performance before illumination, that is, an initial $V_{OC}$ of 0.66 V and efficiency of 4.3%. After illumination of the device under one sun for tens of seconds, the $V_{OC}$ increased to 1.02 V and the device efficiency increased to 8.1%. This can be explained by the ion migration driven by the photovoltage promoting the formation of a favorable p–i–n structure. This discovery is very promising, because it implies that the ion migration in OTP solar cells actually improves device efficiency rather than reducing device efficiency. It also explains that why the state-of-the-art perovskite solar cells still have a very long lifetime of thousand hours at accelerated testing conditions where the presence of ion migration under illumination is expected. The LISP effect should be general and independent of the device structures. It has been sometimes ignored, because usually the devices have been unintentionally illuminated by strong light at open-circuit conditions before $J–V$ measurement or the devices have been optimized to have maximum efficiency or suppressed ion migration.

5. SUPPRESSION OF ION MIGRATION IN OTP FILMS

Although it is not known yet whether the presence of ion migration is beneficial or harmful to the long-term stability of the OTP solar cells, there have been tremendous efforts to eliminate the photocurrent hysteresis caused by ion migration. To suppress the ion migration in OTPs, the first question to be identified is through which channel, grain boundary or bulk, ions migrate dominantly in regular polycrystalline solar cell films.

Recent studies showed that ion migration through grain boundaries might dominate although bulk migration cannot be completely excluded. One typical observation is that the devices with large OTP grains generally have less photocurrent hysteresis. Among all the device structure reported, the “inverted” planar heterojunction structure device with a fullerene buffer layer generally does not show photocurrent hysteresis. It was explained by Shao et al. that fullerene could diffuse into grain boundaries and passivate the charge traps at OTP grain surface and grain boundaries (Figure 5a,b). We speculate that the fullerene–defect interaction at grain boundaries also reduces the ion diffusion by blocking the grain boundary channels, as well as strengthens the bonding.

The recent demonstration of photostable MAPbBr$_{1.5−x}$I$_x$ mixed halide perovskite also highlighted the importance of improved crystallinity and reduced grain boundary area in stabilizing the material under illumination. By replacing PEDOT:PSS with a nonwetting hole transport layer of poly(triarylamine) (PTAA), Bi et al. increased the grain lateral size of MAPbI$_3$ to be several times larger than film thickness. Hu et al. applied this technique to increase the grain size of MAPbBr$_{1.5−x}$I$_x$ (x < 1) films from ~200 nm to >1 μm. XRD and other optical measurements proved that the photoinduced phase separation in MAPbBr$_{1.5−x}$I$_x$ did not occur in the film with large grains (Figure 5g,h). Meanwhile, the efficiency and stability of the MAPbBr$_{1.5−x}$I$_x$ solar cells was also significantly increased due to the absence of low-bandgap impurity phase and reduced grain boundary traps.

If bulk ion migration is also severe, particularly under illumination, the chemical structures of hybrid perovskite will have to be modified. Increasing the valence charges of the ions is an approach to increase the Columbic interaction between the ions and the crystal frame, which is a general way to reduce ion migrations. Codoping cations with higher and lower valence ions might be another possible strategy. However, the

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Figure 4. (a) XRD peak of a MAPbBr$_{1.5−x}$I$_x$ film before and after light illumination. (b) Photoluminescence spectrum change caused by the photoinduced phase separation in the MAPbBr$_{1.5−x}$I$_x$ film. Reproduced with permission form ref 30. Copyright 2015 Royal Society of Chemistry. (c, d) $J–V$ and steady photocurrents of perovskite solar cells with a structure of ITO/PEDOT:PSS/MAPbI$_3$/Au. (e, f) Illustration of ion migration and energy diagram of the device before and after light-soaking. Reproduced with permission form ref 32. Copyright 2015 Wiley.
modification of perovskite structure might also take away the fantastic optoelectronic properties of the hybrid perovskite, which give rise to the extraordinary photovoltaic performance. Further understanding of why hybrid perovskite materials work so well for photovoltaics is thus needed to guide the material structure design.

6. CONCLUSIONS AND OUTLOOK

There has been tremendous understanding of ion migration in the OTPs in such a short time. Much direct and indirect evidence overwhelmingly confirmed that ion migration occurs in OTP polycrystalline materials in many circumstances. So far, more studies are needed to address many still open questions to fully understand its impact to perovskite solar cells. The following: (1) Do I− and H+ ions migrate at room temperature in solar grade perovskite films? (2) Is ion migration present in optimized devices that do not show photocurrent hysteresis? (3) What are the major ion migration channels in polycrystalline solar cell films? (4) Does ion migration impact the long-term stability of the solar cells? (5) How should we change the structure of OTPs to suppress the ion migration without impacting their optoelectronic properties?

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Notes

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